Amendments to the Claims:

This listing of claims will replace all prior versions, and listings, of claims in the application:

Listing of Claims:

Claims 1-60 (deleted)

- 61. (new) A voltage tunable photodetector for sensing combined passive LWIR or MWIR radiation of a scene and active SWIR radiation of a laser source, comprising a quantum well infrared photodetector (QWIP) integrated together with a heterojunction bipolar phototransistor (HBPT).
- 62. (new) The voltage tunable photodetector of claim 61 wherein said active SWIR radiation is sensed by means of the HBPT, when a first predetermined bias voltage is applied across said voltage tunable photodetector, and said passive LWIR or MWIR radiation is sensed by means of the QWIP, when a second predetermined bias voltage is applied across said voltage tunable photodetector.
- 63. (new) The voltage tunable photodetector of claim 61 wherein the QWIP includes a stack of epitaxial layers deposited

on a substrate layer and the HBPT includes another stack of epitaxial layers grown on said QWIP.

- 64. (new) The voltage tunable photodetector of claim 63 wherein said substrate layer is made of a material selected from GaAs and InP.
- 65. (new) The voltage tunable photodetector of claim 63 wherein the epitaxial layers include a first contact layer arranged underside of the QWIP layers and a second contact layer arranged at the upperside of the HBPT layers.
- 66. (new) The voltage tunable photodetector of claim 65 wherein the epitaxial layers include a floating contact layer for providing a contact between said QWIP and said HBPT.
- 67. (new) The voltage tunable photodetector of claim 61 wherein the HBPT includes a stack of epitaxial layers deposited on a substrate layer and the QWIP includes another stack of epitaxial layers grown on said HBPT.
- 68. (new) The voltage tunable photodetector of claim 67 wherein said substrate layer is made of a material selected from GaAs and InP.

- 69. (new) The voltage tunable photodetector of claim 67 wherein the epitaxial layers include a first contact layer arranged underside of the HBPT layers and a second contact layer arranged at the upperside of the QWIP layers.
- 70. (new) The voltage tunable photodetector of claim 69 wherein the epitaxial layers include a floating contact layer for providing a contact between said QWIP and said HBPT.
- 71. (new) The voltage tunable photodetector of claim 64 wherein said QWIP includes GaAs based quantum wells and AlGaAs based barrier layers.
- 72. (new) The voltage tunable photodetector of claim 64 wherein said QWIP includes ${\rm In_{0.53Ga_{0.47}As}}$ quantum wells and InP based barrier layers.
- 73. (new) The voltage tunable photodetector of claim 64 wherein said QWIP includes $In_{0.73}Ga_{0.27}As_{0.63}P_{0.37}$ quantum wells and InP based barrier layers.
- 74. (new) The voltage tunable photodetector of claim 61 wherein said HBPT includes:

an emitter constituted by at least one n-type epitaxial layer;

- a base arranged downstream of said emitter and constituted by at least one p-type epitaxial layer; multiple quantum well elements arranged downstream of said base and configured for absorbing the SWIR radiation; and
- a collector arranged downstream of said multiple quantum well elements and constituted by at least one n-type epitaxial layer.
- 75. (new) The voltage tunable photodetector of claim 74 wherein said at least one n-type epitaxial layer of the emitter is a layer based on at least one element selected from the group including AlGaAs and InP.
- 76. (new) The voltage tunable photodetector of claim 74 wherein said at least one p-type epitaxial layer of the base is a layer based on at least one element selected from the group including GaAs, $In_{0.53}Ga_{0.47}As$ and $In_{0.73}Ga_{0.27}As_{0.63}P_{0.37}$.
- 77. (new) The voltage tunable photodetector of claim 74 wherein said multiple quantum well elements comprise GaAs based barrier and InGaAs based quantum wells layers.

- 78. (new) The voltage tunable photodetector of claim 74 wherein said multiple quantum well elements comprise InP barrier and $In_{0.53}Ga_{0.47}As$ quantum wells layers.
- 79. (new) The voltage tunable photodetector of claim 74 wherein said multiple quantum well elements comprise InP barrier and $In_{0.73}Ga_{0.27}As_{0.63}P_{0.37}$ quantum wells layers.
- 80. (new) The voltage tunable photodetector of claim 74 wherein said at least one n-type epitaxial layer of the collector is a layer based on at least one element selected from the group including GaAs, $In_{0.53}Ga_{0.47}As$ and $In_{0.73}Ga_{0.27}As_{0.63}P_{0.37}$.
- 81. (new) The voltage tunable photodetector of claim 74 wherein the HBPT is being operated in a floating base mode.
- 82. (new) An integrated thermal imager for detecting combined passive LWIR or MWIR radiation of a scene and active SWIR radiation of a laser source, comprising a two-dimensional focal plane array (2D-FPA) constituted by an assembly of voltage tunable photodetectors,

wherein each voltage tunable photodetector integrates a quantum well infrared photodetector (QWIP) together with a

heterojunction bipolar phototransistor (HBPT), thereby forming a pixel element in the 2D-FPA.

- 83. (new) A method of operating a integrated thermal imager for detecting combined passive LWIR or MWIR radiation of a scene and active SWIR radiation of a laser source, wherein said integrated thermal imager includes a two-dimensional focal plane array (2D-FPA) constituted by an assembly of voltage tunable photodetectors, wherein each voltage tunable photodetector integrates a quantum well infrared photodetector (QWIP) together with a heterojunction bipolar phototransistor (HBPT), thereby forming a pixel element in the 2D-FPA, the method comprising:
 - (a) obtaining said passive LWIR or MWIR radiation along with said active SWIR radiation, and converting the radiation into photo-current;
 - (b) applying a first predetermined bias voltage across said voltage tunable photodetector for sensing said active SWIR radiation by means of the HBPT,
 - across said voltage tunable photodetector for sensing said passive LWIR or MWIR radiation by means of the QWIP; and the scene and

(d) creating an image of at least a portion of the scene and the laser source.

84. (new) The method of claim 83 wherein said integrated thermal imager being operable in at least one imaging mode selected from a synchronized imaging mode, a non-synchronized imaging mode, an imaging of the pure active SWIR radiation and an imaging of the pure passive LWIR or MWIR radiation.